Power MOSFET 9.0 A, 60 V, N-Channel DPAK/IPAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit	
Drain-to-Source Voltage	V _{DSS}	60	Vdc	
Drain-to-Gate Voltage ($R_{GS} = 10 \text{ M}\Omega$)	V_{DGR}	60	Vdc	
Gate-to-Source Voltage - Continuous - Non-repetitive (t _p ≤10 ms)	V _{GS} V _{GS}	±20 ±30	Vdc	
Drain Current - Continuous @ $T_A = 25^{\circ}C$ - Continuous @ $T_A = 100^{\circ}C$ - Single Pulse ($t_p \le 10 \mu s$)	I _D I _D	9.0 3.0 27	Adc Apk	
	P _D	28.8 0.19 2.1 1.5	W W/°C W W	
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	°C	
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 25$ Vdc, $V_{GS} = 10$ Vdc, $L = 1.0$ mH, $I_L(pk) = 7.75$ A, $V_{DS} = 60$ Vdc)	E _{AS}	30	mJ	
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA}$	5.2 71.4 100	°C/W	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

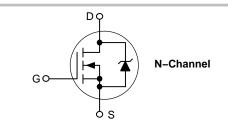
- 1. When surface mounted to an FR4 board using 0.5 sq in pad size.
- When surface mounted to an FR4 board using minimum recommended pad size.



ON Semiconductor®

http://onsemi.com

9.0 AMPERES, 60 VOLTS $R_{DS(on)} = 122 \text{ m}\Omega \text{ (Typ)}$



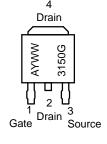


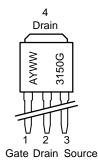




IPAK CASE 369D (STRAIGHT LEAD) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS





A = Assembly Location*
3150 = Device Code
Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

^{*} The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Cha	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS				•	•	•
Drain-to-Source Breakdown Voltage (Note 3) (V _{GS} = 0 Vdc, I _D = 250 µAdc) Temperature Coefficient (Positive)		V _{(BR)DSS}	60 -	- 70.2	_ _	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$		I _{DSS}	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V	I _{GSS}	_	-	±100	nAdc	
ON CHARACTERISTICS (Note:	3)		1	•	•	•
Gate Threshold Voltage (Note 3 $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coeffici	V _{GS(th)}	2.0	3.0 6.4	4.0 -	Vdc mV/°C	
Static Drain-to-Source On-Res (V _{GS} = 10 Vdc, I _D = 4.5 Adc)	R _{DS(on)}	-	122	150	mΩ	
Static Drain-to-Source On-Volto ($V_{GS} = 10 \text{ Vdc}$, $I_D = 9.0 \text{ Adc}$) ($V_{GS} = 10 \text{ Vdc}$, $I_D = 4.5 \text{ Adc}$,	V _{DS(on)}		1.4 1.1	1.9 -	Vdc	
Forward Transconductance (No	9FS	-	5.4	_	mhos	
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	_	200	280	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C _{oss}	_	70	100	
Transfer Capacitance	,	C _{rss}	_	26	40	
SWITCHING CHARACTERISTIC	CS (Note 4)					
Turn-On Delay Time		t _{d(on)}	-	11.2	25	ns
Rise Time	$(V_{DD} = 48 \text{ Vdc}, I_D = 9.0 \text{ Adc},$	t _r	-	37.1	80	
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc},$ $R_G = 9.1 \Omega) \text{ (Note 3)}$	t _{d(off)}	-	12.2	25	
Fall Time		t _f	-	23	50	
Gate Charge		Q _T	-	7.1	15	nC
	$(V_{DS} = 48 \text{ Vdc}, I_D = 9.0 \text{ Adc}, V_{GS} = 10 \text{ Vdc}) \text{ (Note 3)}$	Q ₁	-	1.7	-	
		Q_2	_	3.5	-	1
SOURCE-DRAIN DIODE CHAR	ACTERISTICS		1	•	•	•
Forward On-Voltage	$(I_S = 9.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 3)}$ $(I_S = 19 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$	V_{SD}	-	0.98 0.86	1.20 –	Vdc
Reverse Recovery Time		t _{rr}	-	28.9	-	ns
	$(I_S = 9.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A}/\mu\text{s}) \text{ (Note 3)}$	ta	-	21.6	-	
		t _b	_	7.3	-	
Reverse Recovery Stored Char	ge	Q _{RR}	_	0.036	_	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width $\leq 300~\mu s$, Duty Cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

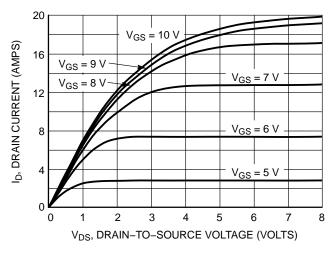


Figure 1. On-Region Characteristics

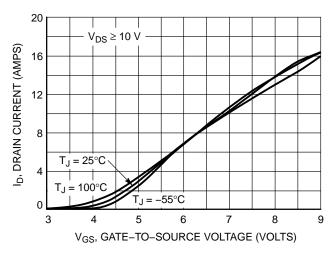


Figure 2. Transfer Characteristics

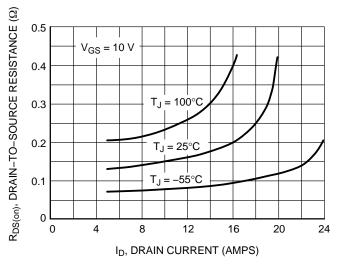


Figure 3. On–Resistance versus Gate–To–Source Voltage

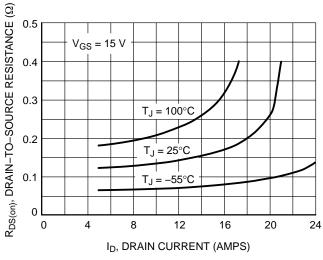


Figure 4. On-Resistance versus Drain Current and Gate Voltage

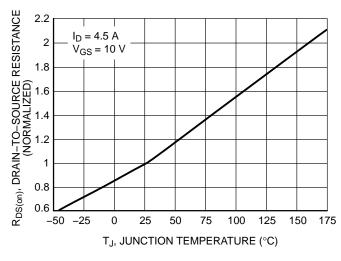


Figure 5. On–Resistance Variation with Temperature

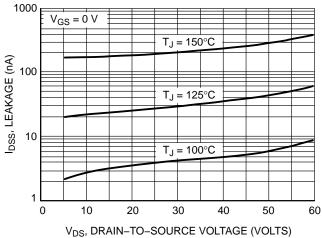


Figure 6. Drain-To-Source Leakage Current versus Voltage

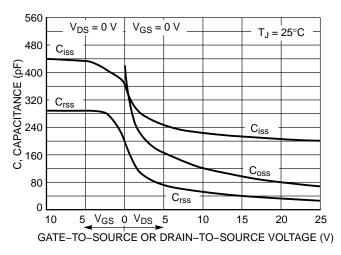


Figure 7. Capacitance Variation

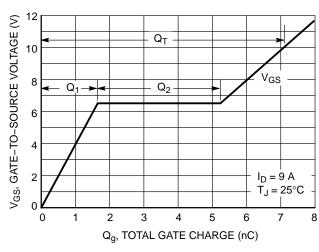


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

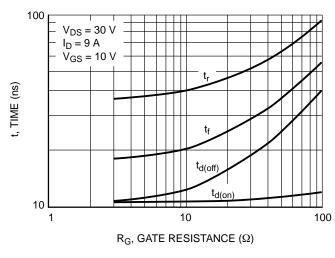


Figure 9. Resistive Switching Time Variation versus Gate Resistance

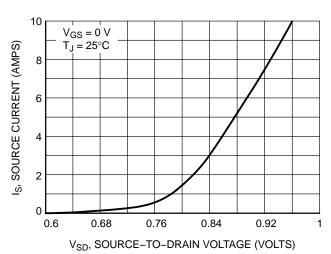


Figure 10. Diode Forward Voltage versus Current

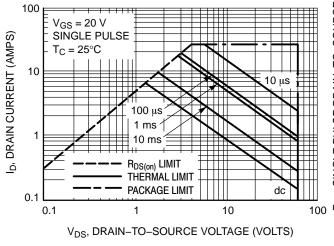


Figure 11. Maximum Rated Forward Biased Safe Operating Area

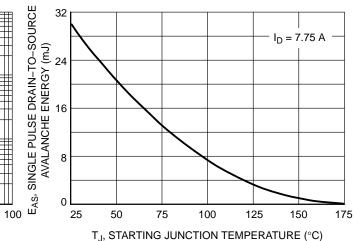


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

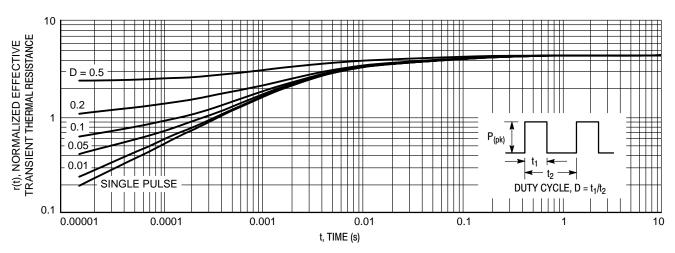


Figure 13. Thermal Response

ORDERING INFORMATION

Device	Package	Shipping †
NTD3055-150G	DPAK (Pb-Free)	75 Units / Rail
NTD3055-150-1G	IPAK (Pb-Free)	75 Units / Rail
NTD3055-150T4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD3055-150T4H	DPAK (Halide-Free)	2500 / Tape & Reel
NVD3055-150T4G*	DPAK (Pb-Free)	2500 / Tape & Reel

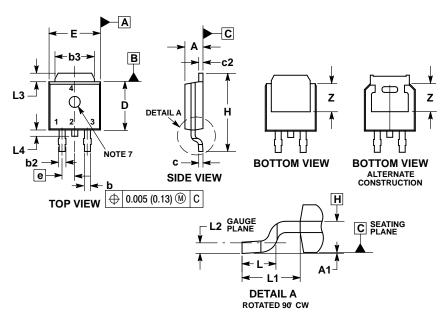
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C ISSUE E



NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

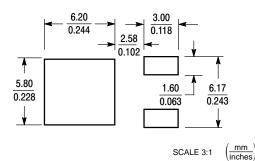
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90 REF		
L2	0.020	0.020 BSC		BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*

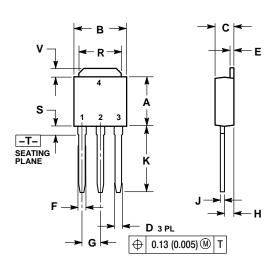


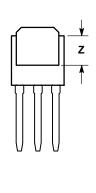
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

IPAK CASE 369D **ISSUE C**





NOTES

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- 2. DRAIN
- 3. SOURCE DRAIN

ON Semiconductor and the 👊 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent–Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights of others. SCILLC products are not designed, intended, a customer application is extended in surface in involved for a content of the respective product is extended for a content of the customer of the product are not designed, intended, and the purport of customer is extended for a content of the customer of the customer is extended for a content of the product are not designed in the hold of the customer is extended for a content of the customer is extended. or authorized for use as components in systems intended for surgical implant into body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada **Fax**: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative